

**Search Notes**

Application/Control No.

10/721,075

Examiner

M. Alexandra Elve

Applicant(s)/Patent under  
Reexamination

TANAKA, KOICHIRO

Art Unit

1725

**SEARCHED**

Class	Subclass	Date	Examiner
update			
219	121.76	12/27/2005	MAE
219	121.78	12/27/2005	MAE
219	121.81	12/27/2005	MAE
219	121.85	12/27/2005	MAE
219	121.65	12/27/2005	MAE
219	121.66	12/27/2005	MAE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
update US OCR, US PAT, US PG, Derwent, JPO, EPO	12/27/2005	MAE